

Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/602,462	BEDELL ET AL.
Examiner	Art Unit
Tianjie Chen	2627

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
360	126		
360	317	2/12/2008	TJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**